International

AUTOMOTIVE GRADE

Features

- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this HEXFET[®] Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.





Tree GDS
TO-220AB
AUIRF1324

G	D	S
Gate	Drain	Source

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T_A) is 25°C, unless otherwise specified.

Parameter	Max.	Units
Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	353 ①	
Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	249 ①	
Continuous Drain Current, V _{GS} @ 10V (Package Limited)	195	— A
Pulsed Drain Current ②	1412	
Maximum Power Dissipation	300	W
Linear Derating Factor	2.0	W/°C
Gate-to-Source Voltage	± 20	V
Single Pulse Avalanche Energy (Thermally Limited) 3	270	mJ
Avalanche Current 2	See Fig. 14, 15, 22a, 22b	А
Repetitive Avalanche Energy ③		mJ
Peak Diode Recovery @	0.46	V/ns
Operating Junction and		
Storage Temperature Range	-55 10 + 175	°C
Soldering Temperature, for 10 seconds (1.6mm from case)	300	
Mounting torque, 6-32 or M3 screw	10lb·in (1.1N·m)	
tance		•
	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) Continuous Drain Current, V _{GS} @ 10V (Package Limited) Pulsed Drain Current @ Maximum Power Dissipation Linear Derating Factor Gate-to-Source Voltage Single Pulse Avalanche Energy (Thermally Limited) @ Avalanche Current @ Repetitive Avalanche Energy @ Operating Junction and Storage Temperature Range Soldering Temperature, for 10 seconds (1.6mm from case)	Continuous Drain Current, VGS @ 10V (Silicon Limited)353 ①Continuous Drain Current, VGS @ 10V (Silicon Limited)249 ①Continuous Drain Current, VGS @ 10V (Package Limited)195Pulsed Drain Current ②1412Maximum Power Dissipation300Linear Derating Factor2.0Gate-to-Source Voltage± 20Single Pulse Avalanche Energy (Thermally Limited) ③270Avalanche Current ②See Fig. 14, 15, 22a, 22bRepetitive Avalanche Energy ③0.46Operating Junction and Storage Temperature Range-55 to + 175Soldering Temperature, for 10 seconds (1.6mm from case)300Mounting torque, 6-32 or M3 screw10lb·in (1.1N·m)

Symbol	Parameter	Тур.	Max.	Units
R _{eJC}	Junction-to-Case ®		0.50	
R _{ecs}	Case-to-Sink, Flat Greased Surface	0.50		°C/W
R _{eJA}	Junction-to-Ambient		62	

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*Qualification standards can be found at http://www.irf.com/

Static Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

<u> </u>			-			,
Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	24			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		22		mV/°C	Reference to 25°C, $I_D = 5.0 \text{mA}$
R _{DS(on)}	Static Drain-to-Source On-Resistance		1.2	1.5	mΩ	V _{GS} = 10V, I _D = 195A
V _{GS(th)}	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
gfs	Forward Transconductance	180			S	V _{DS} = 10V, I _D = 195A
R _G	Internal Gate Resistance		2.3		Ω	
I _{DSS}	Drain-to-Source Leakage Current		_	20	μA	$V_{DS} = 24V, V_{GS} = 0V$
				250		$V_{DS} = 24V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			200	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-200		V _{GS} = -20V

Dynamic Electrical Characteristics $\overset{\circ}{@}$ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Q _g	Total Gate Charge		160	240		I _D = 195A
Q _{gs}	Gate-to-Source Charge		84		nC	$V_{DS} = 12V$
Q _{gd}	Gate-to-Drain ("Miller") Charge		49			V _{GS} = 10V ⑤
Q _{sync}	Total Gate Charge Sync. (Q _g - Q _{gd})		76			$I_{D} = 195A, V_{DS} = 0V, V_{GS} = 10V$
t _{d(on)}	Turn-On Delay Time		17	_		$V_{DD} = 16V$
t _r	Rise Time		190	_	20	I _D = 195A
t _{d(off)}	Turn-Off Delay Time		83		ns	$R_{G} = 2.7\Omega$
t _f	Fall Time		120			V _{GS} = 10V ⑤
C _{iss}	Input Capacitance		7590			$V_{GS} = 0V$
C _{oss}	Output Capacitance		3440			$V_{DS} = 24V$
C _{rss}	Reverse Transfer Capacitance		1960		pF	f = 1.0 MHz, See Fig. 5
C _{oss} eff. (ER)	Effective Output Capacitance (Energy Related)	_	4700			$V_{GS} = 0V, V_{DS} = 0V$ to 19V \odot , See Fig. 11
C _{oss} eff. (TR)	Effective Output Capacitance (Time Related)		4490			$V_{GS} = 0V, V_{DS} = 0V$ to 19V ©

Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current			3530		MOSFET symbol
	(Body Diode)			555	Α	showing the
I _{SM}	Pulsed Source Current			1412		integral reverse
	(Body Diode) ②			1412		p-n junction diode.
V _{SD}	Diode Forward Voltage			1.3	V	T_J = 25°C, I_S = 195A, V_{GS} = 0V \odot
t _{rr}	Reverse Recovery Time		46		20	$T_J = 25^{\circ}C$ $V_R = 20V$,
			71		ns	$T_{J} = 125^{\circ}C$ $I_{F} = 195A$
Q _{rr}	Reverse Recovery Charge		160			T _J = 25°C di/dt = 100A/µs ⑤
			430			T _J = 125°C
I _{RRM}	Reverse Recovery Current		7.7		Α	$T_J = 25^{\circ}C$
t _{on}	Forward Turn-On Time	Intrins	c turn-	on time	is negl	igible (turn-on is dominated by LS+LD)

Notes:

- ① Calcuted continuous current based on maximum allowable junction temperature Bond wire current limit is 195A. Note that current limitation arising from heating of the device leds may occur with some lead mounting arrangements.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- 3 Limited by T_Jmax, starting T_J = 25°C, L = 0.014mH
- R_G = 25 $\Omega,~I_{AS}$ = 195A, V_{GS} =10V. Part not recommended for use above this value .
- $(I_{SD} \le 195A, di/dt \le 450 A/\mu s, V_{DD} \le V_{(BR)DSS}, T_J \le 175^{\circ}C.$

- \bigcirc Pulse width \leq 400µs; duty cycle \leq 2%.
- $\odot~C_{oss}$ eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% $V_{DSS}.$
- $\circledast\ R_{\theta} \, is \, measured \, at \, T_{J} \, approximately \, 90^{\circ}C$

Qualification Information[†]

		Automotive (per AEC-Q101) ^{††}				
		Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
Moisture Sensitivity Level		D2Pak MSL1				
			N/A			
	Machine Model	Class M4				
		AEC-Q101-002				
	Human Body Model	Class H3A				
ESD	ESD		AEC-Q101-001			
	Charged Device Model	Class C5				
		AEC-Q101-005				
RoHS Compl	iant		Yes			

† Qualification standards can be found at International Rectifier's web site: http://www.irf.com/

†† Exceptions to AEC-Q101 requirements are noted in the qualification report.

International **TOR** Rectifier







 V_{GS} , Gate-to-Source Voltage (V)









Fig 2. Typical Output Characteristics







Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage www.irf.com

International **TOR** Rectifier





10000

AUIRF1324



Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case



tav (sec) Fig 14. Typical Avalanche Current vs.Pulsewidth

International **TOR** Rectifier



Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.irf.com) 1. Avalanche failures assumption:

Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{imax} . This is validated for every part type.

- 2. Safe operation in Avalanche is allowed as long asT_{imax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
- 4. $P_{D (ave)}$ = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. Δ T = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).
 - t_{av =} Average time in avalanche.

D = Duty cycle in avalanche = $t_{av} \cdot f$

 $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \text{ (ave)}} &= 1/2 \text{ (} 1.3 \cdot \text{BV} \cdot I_{av} \text{)} = \bigtriangleup \text{T} / \text{Z}_{thJC} \\ I_{av} &= 2 \bigtriangleup \text{T} / \text{ [} 1.3 \cdot \text{BV} \cdot \text{Z}_{th} \text{]} \\ E_{AS \text{ (AR)}} &= P_{D \text{ (ave)}} \cdot t_{av} \end{split}$$





Fig 16. Threshold Voltage vs. Temperature



* V_{GS} = 5V for Logic Level Devices





Fig 22a. Unclamped Inductive Test Circuit



Fig 23a. Switching Time Test Circuit



Fig 24a. Gate Charge Test Circuit



Fig 22b. Unclamped Inductive Waveforms



Fig 23b. Switching Time Waveforms



Fig 24b. Gate Charge Waveform

TO-220AB Package Outline

Dimensions are shown in millimeters (inches)





		DIMEN	SIONS		
SYMBOL	MILLIN	ETERS	INC	HES	
	MIN.	MAX.	MIN.	MAX.	NOTES
A	3.56	4.82	.140	.190	
A1	0.51	1.40	.020	.055	
A2	2.04	2.92	.080	.115	
b	0.38	1.01	.015	.040	
b1	0.38	0.96	.015	.038	5
b2	1.15	1,77	,045	.070	
b3	1.15	1.73	.045	.068	
с	0.36	0.61	.014	.024	
c1	0.36	0.56	.014	.022	5
D	14.22	16.51	.560	.650	4
D1	8.38	9.02	.330	.355	
D2	12.19	12.88	,480	.507	7
E	9.66	10.66	.380	.420	4,7
E1	8.38	8.89	.330	.350	7
e	2.54	BSC	.100		1
e1 –	5,	08	.200	BSC	-
H1	5.85	6.55	.230	.270	7,8
L	12.70	14.73	,500	.580	
L1	-	6.35	-	.250	3
øР	3.54	4.08	.139	.161	
Q	2,54	3.42	.100	.135	
ø	90*-	-93'	90*	-93'	

DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.

LEAD DIMENSIon AND FINSH ONCONTROLLED IN ET. DIMENSION D & E DO NOT INCLUDE WOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005° (0.127) PER SIDE, THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY, DIMENSION b1 & c1 APPLY TO BASE METAL ONLY, CONTROLLING DIMENSION : INCHES.

THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1

DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS]. LEAD DIMENSION AND FINISH UNCONTROLLED IN L1

DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING

LEAD ASSIGNMENTS

HEXFET 1.- GATE 2.- DRAIN 3.- SOURCE

IGBTs, CoPACK

1.- GATE 2.- COLLECTOR 3.- EMITTER

DIODES

1.- ANODE/OPEN 2.- CATHODE 3.- ANODE

SYMBOL	MILLIM	ETERS	INC	HES	
	MIN.	MAX.	MIN.	MAX.	NOTES
A	3.56	4.82	.140	.190	
A1	0.51	1,40	.020	.055	
A2	2.04	2.92	.080	.115	
b	0.38	1.01	.015	.040	
b1	0.38	0.96	.015	.038	5
b2	1.15	1.77	.045	.070	
b3	1.15	1.73	.045	.068	
с	0.36	0.61	.014	.024	
c1	0.36	0.56	.014	.022	5
D	14.22	16.51	.560	.650	4
D1	8.38	9.02	.330	.355	
D2	12.19	12.88	.480	.507	7
E	9.66	10.66	.380	.420	4,7
E1	8.38	8.89	.330	.350	7
e	2.54		.100		1
e1	5,1	08	.200	BSC	
H1	5.85	6.55	.230	.270	7,8
L	12.70	14.73	,500	.580	
L1	-	6.35	-	.250	3
øР	3.54	4.08	.139	.161	
Q	2.54	3.42	.100	.135	
ø	90*-	-93'	90*	-93'	1

TO-220AB Part Marking Information



NOTES:

1

2

3

4

/5\

8

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

Ordering Information

Base part	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRF1324	TO-220	Tube	50	AUIRF1324

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For technical support, please contact IR's Technical Assistance Center

http://www.irf.com/technical-info/

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